

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/510,637 TAKAMINE ET AL.	
		Examiner	Art Unit CHAU NGUYEN	2176 Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0111035	05-2005	Takamine, Kouichi	358/001.15
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 1494113 A1	01-2005	European Patent	TAKAMINE et al.	
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**NON-PATENT DOCUMENTS**

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